The interface between a polar perovskite oxide and silicon from

m onoatom ic lines

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Abstract

We report a study on the interface between polar high- materials and the $Si(001)-(2 \ 1)$ reconstructed surface with LaA D₃ taken as a prototype material. The construction of the interface is based on the prior grow th of metal lines followed by oxidation, whose stability against oxygen coverage is studied. Electronic structure calculations within the Density Functional Theory framework help in building the interface and understanding its bonding structure. Moreover, we computed a conduction band o set of 1.9 eV, in agreement with electronic applications requirement. The results may provide a guidance for interface processing.

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The search for alternative dielectrics to silicon dioxide in MOS capacitors has recently focused on complex oxide materials with high dielectric constant (high-materials). Many of them belong to the class of perovskites (cubic crystals whose chemical formula is ABO₃) which are thought to have a good ability to grow as crystalline lms. However, the interface with Si is of crucial importance as it must avoid gap states and be structurally compatible with the lm's crystallographic structure. In the search of the best candidate, the LaA D₃ crystalraised out of the perovskite family. This was partly due to its lowerm ismatch with the Si(001) surface (0.7 %). Moreover, the conduction band o set is expected to be greater than 1 eV. A value has been computed [L] to be 1 eV within the "charge neutrality levelm odel" which does not take the interface structure into account. Nevertheless, as La, Al and 0 respective oxidation states are + III, + III and -II, the A D₂ and LaO layers are respectively charged with -1 and +1 electron which makes it a polar crystal. This polar aspect leads to a more complex interface construction than dealing with non polar perovskites.

This letter focuses on the interface between a polar perovskite and Si(100)-p (2 1), taking LaA D₃ as a prototype. The interface m ay start with the deposition of La or A latom s. For an interface starting with La, A shm an et al. [2] have shown that La atom s cover the Si surface by pairs. This scheme is coherent with the "electron counting model" where 2 La atom s provide 6 electrons to 6 Si dangling bonds, removing gap states and assuming a coverage of 2=3 m onolayer (M L). K lenov et al. [3] have grown a Sithin lm on a LaA D₃ substrate and m icroscopy has shown that the interface w as based on La pairs. This interface has been theoretically studied by Forst et al. [4] to de ne the interface's Si and O networks that can not be resolved by the m icroscopy. The Si network obtained by Si epitaxy is not clearly coherent with LaA D₃ epitaxy on the (2 1) reconstructed Si surface. In order to avoid dipole m on ent of the polar surfaces of LaA D₃, K nizhnik et al. [5] have constructed theoretical interfaces by transfering O from one boundary surface to the other in their LaA D₃ slab.

Our aim here is to build an interface starting with A latom deposition, compatible with the growth of LaO -A D_2 neutral bilayers, without m idgap states.

Due to the odd oxidation state of Al (+ III), atom s are arranged by pairs on the Sisurface. Indeed, it is well known for indium, alum inum and so on that the most stable geometry (Fig.1) is realized at a coverage of 1=2 M L by pairs of adatom s form ing m onoatom ic chains [6]. As the coverage of Siby Al lines has been realized ten years ago, we take this surface as a starting point for the growth of LaA D_3 .

The electronic structures were computed thanks to the SIESTA code [7]. We made use of the same pseudopotentials and basis sets as Knizhnik et al. [5]. The atom ic basis for La, Aland O atom swere single-zeta plus polarization, and Sibasis were double-zeta plus polarization. The supercells were fully relaxed in the Harris functional framework (until a maxim un force tolerance of 0.1 eV/A is reached). Then the electronic structure of the relaxed supercellwas calculated in the Self-Consistent-Field framework, using a 2 2 1 k-point grid.

We carried out electronic structure calculations of this A Hines tem plate to get insights on the electron distribution and bonds at the surface. We considered a supercell made of a 7 Si layer slab whose bottom layer was xed and saturated by hydrogen atoms, and top surface was covered by the adatoms and a vacuum slab of 14 A. Charge density maps (Fig.2) show high density regions between top Si atoms and Al atoms, representing the interface's SiAlbonds. We also notice another high density region inside each pair of Al atoms, corresponding to Al-Albonds. Thus, one may understand that a pair of Alprovides 4 electrons to 4 Si dangling bonds while the 2 Alshare 2 electrons, leading to a coverage of 1=2 ML. Electronic densities of states (Fig.3) shows that the half lled state in the band gap of the Si(001)-p (2 1) disappeared in favor of the Si-Albond creation. Therefore, electron counting modelm ust be "extended" to take into account the dimer form ed by the adatom s.

This Si surface covered by half a layer of A lwas then oxidized thanks to two approaches: i) by considering electron counting arguments to obtain a neutral interface, ii) by computing with an ab initio method the energy of the system with one O atom at various positions (A \pm on Fig.1) in order to de net the most stable ones. Let us not count the electrons. In order to construct a neutral interface, one considers that N O atoms need 2N electrons. As the (1 1) surface unit cell provides 2.5 electrons (1 electron from the dangling bonds and 1.5 electrons from the A $l_{0.5}$ M L), the interface is neutral with 1.25 O atoms. Thus, the interface stoichiometry should be A $l_{0.5}O_{1.25}$. Now, within ab initio computations, each of the A \pm site's vertical position was relaxed and the naltotal energy values were compared. A and C sites have sim ilar energies and are more stable than the others by more than 1 eV per supercell. This may be easily understood if one considers the trend of O atoms to go where a high electron density stands (on SiA 1 and A IA 1 bonds). These stable sites were then fully led and lead to the addition of 1.25 O M L which is in agreement with a neutral interface. Let us here mention that the addition of one O atom on each Si-Sibridge (B sites) leads to 1.750 ML which also leads to a neutral interface.

The resulting A $b_{.5}O_{1.25}$ surface was fully relaxed and its electronic structure studied. Si-O bond length is found to be similar to those in SiO₂. A HO distances (from 1.76 to 1.85 A) are compatible with those in an A D₂ plane of LaA D₃. A tom s in the A $b_{.5}O_{1.25}$ layer are nearly in the same plane. Concerning the electronic density of states (Fig.3), the oxidation does not add states in the gap of the A loovered surface, and the Sigap is nally recovered. The same behaviour occurs for A $b_{.5}O_{1.75}$.

In order to de ne further grow th over the A $l_{0.5}O_{1.25}$ layer, the interface was also capped by a neutral LaA D₃ bilayer and both LaO -A D₂ and A D₂-LaO sequences with various in plane positions were constructed and relaxed (F ig.4). Their total energies were found to be equivalent, showing that further grow th on the interface would be similar whatever its structure would be. M oreover, the perovskite structure of the relaxed bilayer wasm aintained, dem onstrating the possibility of growing LaA D₃ over this interface.

The stability of this interface against oxidation was tested using the method proposed by Forst et al.[3]. Figure 5 shows the adsorption energy of 0 atoms per (1 1) surface unit cell for various 0 coverages. When possible, several structures were constructed for a xed coverage, whose lowest energy corresponds to the most stable one. On this basis, our $A \log_5 0_{125}$ interfacial layer is more stable than other lower coverages and coverages higher than 1.75 (which corresponds to $A \log_5 0_{125}$ with SiSi oxidized dimers). Using this gure, the oxygen chemical potential was evaluated to construct the phase diagram for interface oxidation (Fig.6). It shows that: i) for a chemical potential below -0.35 eV, the $A \log_5 0_{125}$ interfacial layer can be form ed without silica, ii) for a chemical potential between -0.35 eV and 0 eV, the SiSi dimers below the $A \log_5 0_{125}$ interfacial layer are oxidized, leading to the $A \log_5 0_{1.75}$ stoichiom etry.

Concerning applications, a key point is the conduction band o set with Si, which is whished to be greater than 1 eV to avoid tunnelling through the oxide barrier. As the interface between the oxide and Sigreatly in uences its value, it is important to evaluate the o set for each interface. We computed this o set for the $A l_{0.5}O_{1.25}$ interface followed by the previous sequences. The computations were realized on supercells built as follow: H - Si slice (13 A) - LaA D_3 (19 A) - Si slice (13 A) - H containing a mirror plane in order to avoid in nite addition of the interface's electronic dipole. The average potential method was used to evaluate the band o sets [9]. The computed conduction band o sets is 1.9 eV which is large enough for m icroelectronics applications. In case of A $b_{25}O_{1:75}$, the o set does not change by m ore than 0.1 eV.

In conclusion, we have derived an interface between a polar high-perovskite and Si. The interface corresponds to the prior grow th of metal lines followed by oxidation. We emphasize that the A $l_{0.5}O_{1.25}$ interface (with orwithout oxidized Si-Sidimers) leads to consider LaA D₃ as a promising material to replace SiO₂ with a conduction band oset of about 1.9 eV. More generally, this result plays in favor of interfaces based on B metal atoms in case of grow th of the polar ABO₃ perovskite on the Si(001)-p (2 1) surface.

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Figure 1. Top (a) and side (b) view of the Allines geometry. The atom ic positions are those corresponding to the total energy minimum as found by our computations. The grey bars link Sidim ers and the black bars link Aldim ers forming the lines. Letters A to F refer to the in plane positions of 0 atoms that are added to the lines.

Figure 2. Charge density m ap of the Allines showing the high density areas (bold lines) along the Al-Si and Al-Albonds (Si and Alatom s are respectively represented by grey and black balls).

Figure 3. Electonic densities of states (DOS) around the theoretical Siband gap, E_G (Si), for various coverages on the Si(001)-p (2 1) surface (from the bottom to the top: free Si surface, $A \downarrow_{0.5}$, $A \downarrow_{0.5} O_{1:25}$ and $A \downarrow_{0.5} O_{1:75}$). The Ferm i level stands at 0 eV. SiAl and SiAl respectively indicate Si-Albonding and anti-bonding states.

Figure 4. Geometry of the relaxed supercell. Views in bulk silicon's [-110] (a) and [110] (b) directions. W hite, black, tiny and wide grey balls correspond respectively to 0, Al, Si and La atom s.

Figure 5. The adsorption energy per (1 1) unit cell as a function of 0 coverage. Open squares represent therm odynam ically accessible structures while triangles correspond to m etastable structures.

Figure 6. One-dimensional phase diagram of the A Hine interface as a function of the O chemical potential. The dashed line at a chemical potential of O eV corresponds to the ∞ -existence of Si and SiO₂ (-quartz).







FIG.2:



FIG.3:



 FIG .4:



FIG.5:



FIG.6: